



## DESCRIPTION

The AL245 is designed for asynchronous communication between two data buses. The logic levels of the direction-control (DIR) input and the output-enable ( $\overline{OE}$ ) input activate either the B-port outputs or the A-port outputs or place both output ports into the high-impedance mode.

The AL245 transmits data from the A bus to the B bus when the B-port outputs are activated, and from the B bus to the A bus when the A-port outputs are activated. The input circuitry on both A and B ports is always active and must have a logic High or Low level applied to prevent excess  $I_{CC}$  and  $I_{CCZ}$ .

This AL245 is fully specified for partial-power-down applications using  $I_{OFF}$ . The  $I_{OFF}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

The  $V_{CC}$  isolation feature ensures that if either  $V_{CC}$  input is at GND, all outputs are in the high-impedance state. To ensure the high-impedance state during power up or power down, ( $\overline{OE}$ ) should be tied to  $V_{CC}$  through a pullup resistor, the minimum value of the resistor is determined by the current-sinking capability of the driver.

The AL245 is available in SOP20 and TSSOP20 packages.

## ORDERING INFORMATION

Package Type	Part Number	
SOP20 SPQ: 1500pcs/Reel	M20	AL245M20R
		AL245M20VR
TSSOP20 SPQ:4,000pcs/Reel	TMX20	AL245TMX20R
		AL245TMX20VR
Note	V: Halogen free Package R: Tape & Reel	
AiT provides all RoHS products		

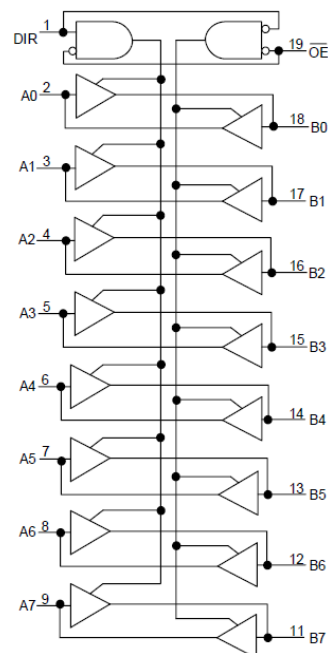
## FEATURES

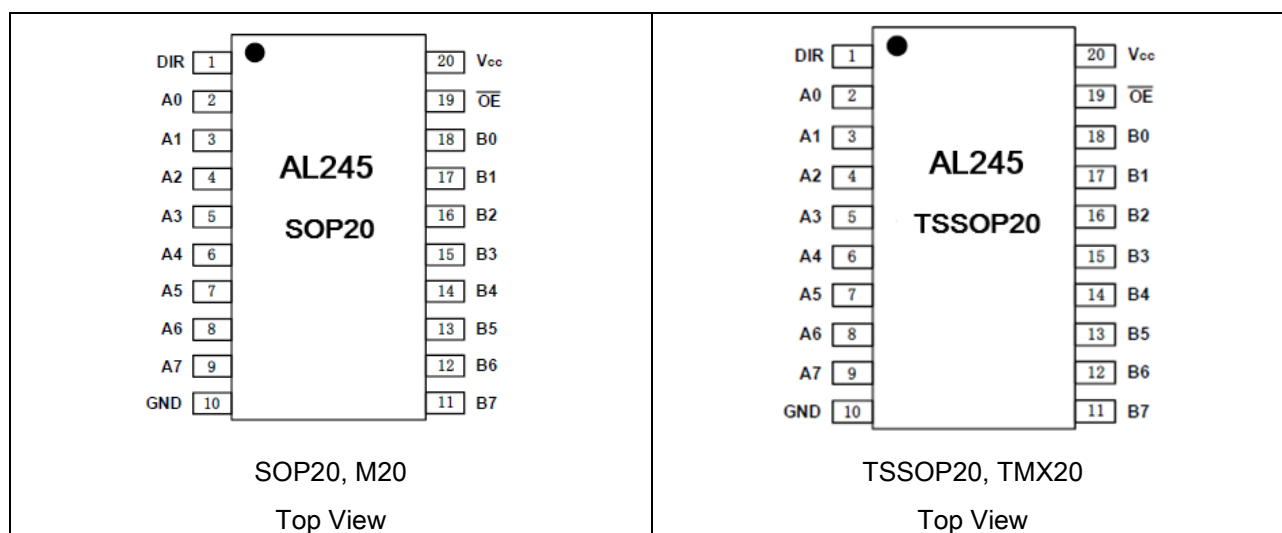
- 1.65V to 5.5V Operation
- $V_{CC}$  Isolation: If  $V_{CC}$  is at GND, Both Ports are in the High-Impedance State
- $I_{OFF}$ : Supports Partial-Power-Down Mode Operation
- Extended Temperature: -40°C to +125°C

## APPLICATION

- Servers
- LED Displays
- Network Switches
- Telecom Infrastructure
- Motor Drivers
- I/O Expanders
- Handset
- Smartphone
- Tablet
- Desktop PC

## FUNCTIONAL BLOCK DIAGRAM



**PIN DESCRIPTION**

Pin #		Symbol	I/O	Function
SOT-25	SC70-5			
1	1	DIR	I	direction control
2	2	A0	I/O	Input/output
3	3	A1	I/O	Input/output
4	4	A2	I/O	Input/output
5	5	A3	I/O	Input/output
6	6	A4	I/O	Input/output
7	7	A5	I/O	Input/output
8	8	A6	I/O	Input/output
9	9	A7	I/O	Input/output
10	10	GND	G	Ground.
11	11	B7	I/O	Input/output
12	12	B6	I/O	Input/output
13	13	B5	I/O	Input/output
14	14	B4	I/O	Input/output
15	15	B3	I/O	Input/output
16	16	B2	I/O	Input/output
17	17	B1	I/O	Input/output
18	18	B0	I/O	Input/output
19	19	$\overline{OE}$	I	Output Enable (Active Low). Pull $\overline{OE}$ high to place all outputs in 3- state mode.
20	20	V <sub>CC</sub>	P	supply voltage. 1.65V≤V <sub>CC</sub> ≤5.5V



## FUNCTION TABLE

Input		Output		OPERATION
$\overline{OE}$	DIR	A PORT	B PORT	
L	L	Enabled	Hi-Z	B data to A
L	H	Hi-Z	Enabled	A data to B
H	X	Hi-Z	Hi-Z	Isolation

H=HIGH voltage level

L=LOW voltage level

X=don't care

Z=high impedance OFF-state

## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range, unless otherwise noted <sup>(1)</sup>

$V_I$ , Input Voltage Range <sup>(2)</sup>	A port	-0.5V ~ 6.5V
	B port	-0.5V ~ 6.5V
	Control inputs	-0.5V ~ 6.5V
$V_O$ <sup>(2)</sup> , Voltage range applied to any output in the high-impedance or power-off state	A port	-0.5V ~ 6.5V
	B port	-0.5V ~ 6.5V
$V_O$ <sup>(2)(3)</sup> , Voltage range applied to any output in the high or low state	A port	-0.5V ~ $V_{CC}+0.5V$
	B port	-0.5V ~ $V_{CC}+0.5V$
$I_{IK}$ , Input Clamp Current	$V_I < 0$	-50mA
$I_{OK}$ , Output Clamp Current	$V_O < 0$	-50mA
$I_O$ , Continuous Output Current		±50mA
Continuous Current Through $V_{CC}$ or GND		±100mA
$T_J$ , Junction Temperature		150°C
$T_{STG}$ , Storage Temperature		-65°C ~ 150°C
<b>ESD Ratings</b>		
$V_{(ESD)}$ , Electrostatic Discharge	Human-body model (HBM)	±3000V
	Machine model (MM)	±400V

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The value of  $V_{CC}$  is provided in the Recommended Operating Conditions table.



## RECOMMENDED OPERATING CONDITIONS

$V_{CC}$  is the supply voltage associated with the input port and output port.<sup>(1)(2)</sup>

Parameter		Symbol	Conditions	Min.	Max.	Unit
Supply Voltage		V <sub>CC</sub>		1.65	5.5	V
High-level input voltage		V <sub>IH</sub>	V <sub>CC</sub> =1.65V to 1.95V	V <sub>CC</sub> ×0.65	-	V
			V <sub>CC</sub> =2.3V to 2.7V	1.7	-	
			V <sub>CC</sub> =3V to 3.6V	2.2	-	
			V <sub>CC</sub> =4.5V to 5.5V	V <sub>CC</sub> ×0.7	-	
Low-level input voltage		V <sub>IL</sub>	V <sub>CC</sub> =1.65V to 1.95V	-	V <sub>CC</sub> ×0.35	V
			V <sub>CC</sub> =2.3V to 2.7V	-	0.7	
			V <sub>CC</sub> =3V to 3.6V	-	0.8	
			V <sub>CC</sub> =4.5V to 5.5V	-	V <sub>CC</sub> ×0.3	
Input voltage		V <sub>I</sub>		0	5.5	V
Input/output voltage	Active state	V <sub>I/O</sub>		0	V <sub>CC</sub>	V
	3-state			0	5.5	V
High-level output current		I <sub>OH</sub>	V <sub>CC</sub> =1.65V to 1.95V	-	-4	mA
			V <sub>CC</sub> =2.3V to 2.7V	-	-8	
			V <sub>CC</sub> =3V to 3.6V	-	-24	
			V <sub>CC</sub> =4.5V to 5.5V	-	-32	
Low-level output current		I <sub>OL</sub>	1.65V to 1.95V	-	4	mA
			V <sub>CC</sub> =2.3V to 2.7V	-	8	
			V <sub>CC</sub> =3V to 3.6V	-	24	
			V <sub>CC</sub> =4.5V to 5.5V	-	32	
Input transition rise or fall rate(Δt/Δv)		Data inputs	V <sub>CC</sub> =1.65V to 1.95V	-	20	ns/V
			V <sub>CC</sub> =2.3V to 2.7V	-	20	
			V <sub>CC</sub> =3V to 3.6V	-	10	
			V <sub>CC</sub> =4.5V to 5.5V	-	5	
T <sub>A</sub> Operating free-air temperature				-40	125	°C

(1) All unused or driven (floating) data inputs (I/Os) of the device must be held at logic High or Low preferably  $V_{CC}$  or GND) to ensure proper device operation and minimize power.

(2) All unused control inputs must be held at  $V_{CC}$  or GND to ensure proper device operation and minimize power consumption.

(3) For  $V_{CC}$  values not specified in the data sheet,  $V_{IH} \text{ min} = V_{CC} \times 0.7 \text{ V}$ ,  $V_{IL} \text{ max} = V_{CC} \times 0.3 \text{ V}$ .



## ELECTRICAL CHARACTERISTICS

Parameter		Conditions	Temp	Min.	Typ.	Max.	Unit
V <sub>OH</sub>		I <sub>OH</sub> = -100μA, V <sub>I</sub> =V <sub>IH</sub> V <sub>CC</sub> =1.65V to 5.5V	-40°C~+125°C	V <sub>CC</sub> -0.1	-	-	V
		I <sub>OH</sub> =-4mA, V <sub>I</sub> =V <sub>IH</sub> V <sub>CC</sub> =1.65V		1.2	-	-	
		I <sub>OH</sub> =-8mA, V <sub>I</sub> =V <sub>IH</sub> V <sub>CC</sub> =2.3V		1.9	-	-	
		I <sub>OH</sub> =-24mA, V <sub>I</sub> =V <sub>IH</sub> V <sub>CC</sub> =3V		2.4	-	-	
		I <sub>OH</sub> =-32mA, V <sub>I</sub> =V <sub>IH</sub> V <sub>CC</sub> =4.5V		3.8	-	-	
V <sub>OL</sub>		I <sub>OL</sub> =100μA, V <sub>I</sub> =V <sub>IL</sub> V <sub>CC</sub> =1.65V to 4.5V	-40°C~+125°C	-	-	0.1	V
		I <sub>OL</sub> =4mA, V <sub>I</sub> =V <sub>IL</sub> V <sub>CC</sub> =1.65V		-	-	0.45	
		I <sub>OL</sub> =8mA, V <sub>I</sub> =V <sub>IL</sub> V <sub>CC</sub> =2.3V		-	-	0.3	
		I <sub>OL</sub> =24mA, V <sub>I</sub> =V <sub>IL</sub> V <sub>CC</sub> =3V		-	-	0.55	
		I <sub>OL</sub> =32mA, V <sub>I</sub> =V <sub>IL</sub> V <sub>CC</sub> =4.5V		-	-	0.55	
I <sub>I</sub>	DIR	V <sub>I</sub> =5.5V or GND, V <sub>CC</sub> = 1.65V to 5.5V	+25°C	-	-	-	μA
			-40°C~+125°C	-	-	-	
I <sub>off</sub>	A or B Port	V <sub>I</sub> or V <sub>O</sub> = 0 to 5.5V, V <sub>CC</sub> =0V	+25°C	-	-	-	μA
I <sub>oz</sub>	A or B Port	V <sub>O</sub> = V <sub>CC</sub> or GND, $\overline{OE}$ =V <sub>IH</sub> V <sub>CC</sub> = 1.65V to 5.5V	+25°C	-	-	-	
			-40°C~+125°C	-	-	-	
I <sub>CC</sub>	A or B Port	V <sub>I</sub> =5.5V or GND, I <sub>O</sub> =0, V <sub>CC</sub> =1.65V to 5.5V	+25°C	-	-	-	μA
			-40°C~+125°C	-	-	-	
ΔI <sub>CC</sub>	A Port	One input at V <sub>CC</sub> - 0.6V, DIR at V <sub>CC</sub> , B port = open V <sub>CC</sub> =3V to 5.5V	-40°C~+125°C	-	-	-	μA
	B Port	One B port at V <sub>CC</sub> - 0.6 V, DIR at GND, A port = open V <sub>CC</sub> =3V to 5.5V					
	DIR	DIR at V <sub>CC</sub> - 0.6 V, B port = open A port at V <sub>CC</sub> or GND					
C <sub>I</sub>	Control inputs	V <sub>I</sub> = V <sub>CC</sub> or GND V <sub>CC</sub> = 3.3V	+25°C	-	-	-	μA
C <sub>IO</sub>	A Port		+25°C	-	8.5	-	pF
	B Port		+25°C	-	8.5	-	pF



## TYPICAL PERFORMANCE CHARACTERISTICS

At  $T_A = 25^\circ\text{C}$   $V_{CC}=5\text{V}$ , (unless otherwise noted)

Fig1 Voltage vs Current

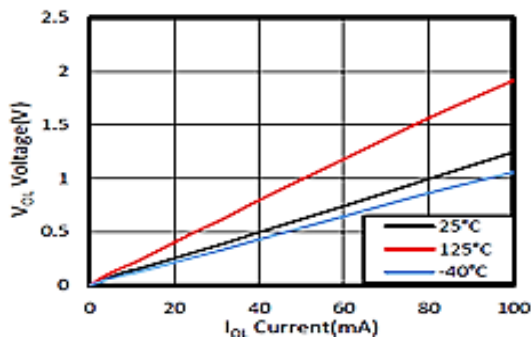
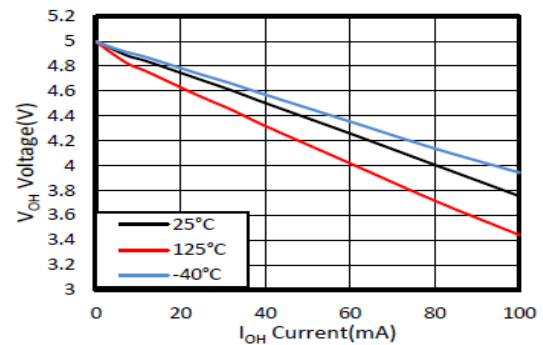


Fig2 Voltage vs Current



## AC ELECTRICAL CHARACTERISTICS

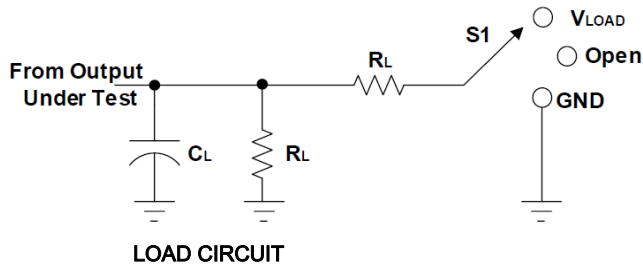
Parameter	Form (Input)	TO (Output)	V <sub>CC</sub> =1.8V ±0.15V		V <sub>CC</sub> =2.5V ±0.2V		V <sub>CC</sub> =3.3V ±0.3V		V <sub>CC</sub> =5V ±0.5 V		Unit
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	An	Bn	1.70	21.6	1.30	9.10	1.0	7.4	0.80	7.10	ns
t <sub>PHL</sub>											
t <sub>PLH</sub>	Bn	An	0.90	23.5	0.80	23.6	0.7	23.3	0.70	23.3	ns
t <sub>PHL</sub>											
t <sub>PHZ</sub>	$\overline{OE}$	An	1.50	29.5	1.50	29.4	1.5	29.3	1.40	29.1	ns
t <sub>PLZ</sub>											
t <sub>PHZ</sub>	$\overline{OE}$	Bn	2.40	32.2	1.90	12.9	1.7	12.0	1.30	10.2	ns
t <sub>PLZ</sub>											
t <sub>PZH</sub>	$\overline{OE}$	An	0.40	23.8	0.40	23.7	0.4	23.7	0.40	23.7	ns
t <sub>PZL</sub>											
t <sub>PZH</sub>	$\overline{OE}$	Bn	1.80	31.9	1.50	16	1.2	12.6	0.90	10.8	ns
t <sub>PZL</sub>											

Parameter		Test Conditions	V <sub>CC</sub> =1.8V	V <sub>CC</sub> =2.5V	V <sub>CC</sub> =3.3V	V <sub>CC</sub> =5V	Unit
			Typ	Typ	Typ	Typ	
C <sub>pd(1)</sub>	A-port input, B-port output	C <sub>L</sub> =0, f=10MHz, t <sub>r</sub> =t <sub>f</sub> =1ns	2	2	2	3	pF
	B-port input, A-port output		42	42	43	44	

(1) Power dissipation capacitance per transceiver

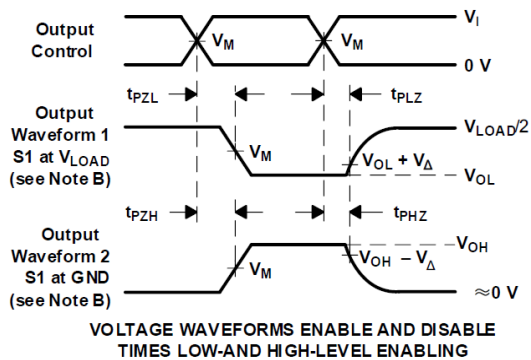
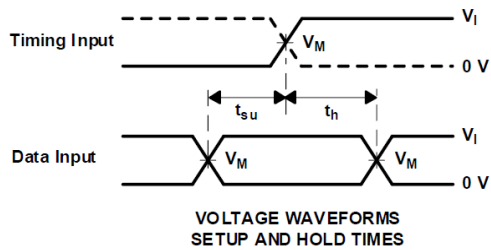
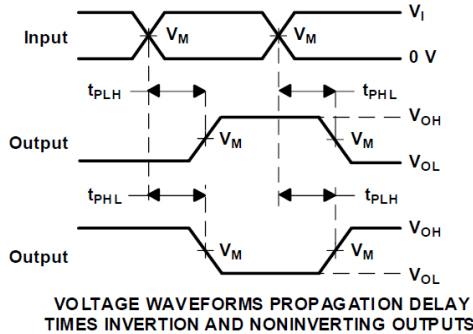
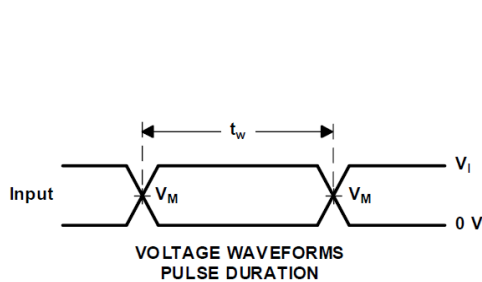


## PARAMETER MEASUREMENT INFORMATION



TEST	S1
$t_{PLH}/t_{PHL}$	Open
$t_{PLZ}/t_{PZL}$	$V_{LOAD}$
$t_{PHZ}/t_{PZH}$	GND

$V_{CC}$	$V_I$	$V_M$	$C_L$	$R_L$	$V_{\Delta}$
$1.8V \pm 0.15V$	$V_{CC}$	$V_{CC}/2$	15pF	2k $\Omega$	0.15V
$2.5V \pm 0.2V$	$V_{CC}$	$V_{CC}/2$	15pF	2k $\Omega$	0.15V
$3.3V \pm 0.3V$	2.7V	1.5V	15pF	2k $\Omega$	0.3V
$5.0V \pm 0.5V$	2.7V	1.5V	15pF	2k $\Omega$	0.3V



NOTE A:  $C_L$  includes probe and jig capacitance.

B: Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control.

Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.

C: All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_o = 50\Omega$ ,  $dv/dt \geq 1V/ns$ . D: The outputs are measured one at a time, with one transition per measurement.

E:  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .

F:  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .

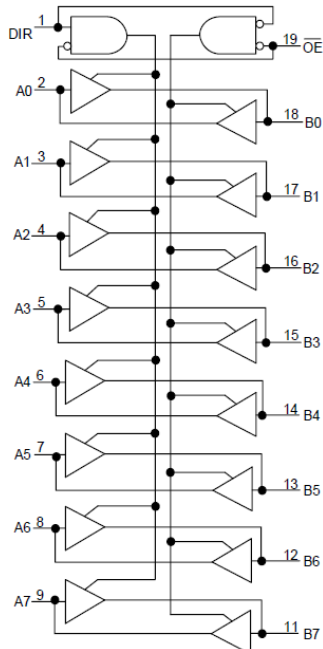
G:  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

H: All parameters and waveforms are not applicable to all devices.

**Fig3. Load Circuit and Voltage Waveforms**

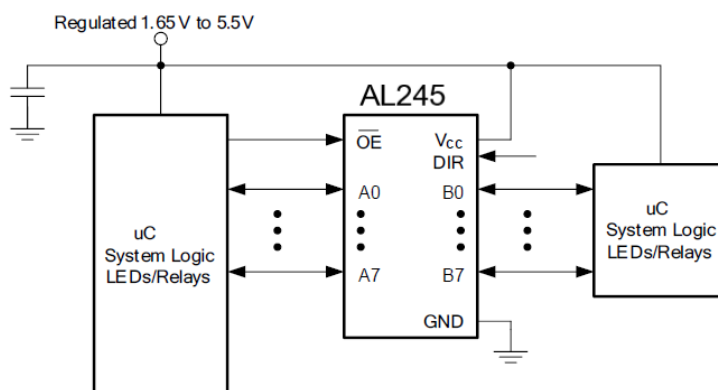


## BLOCK DIAGRAM



## APPLICATION INFORMATION

AL245 is a high drive CMOS device that can be used for a multitude of bus interface type applications where output drive or PCB trace length is a concern. The inputs can accept voltages to 5.5 V at any valid  $V_{CC}$  making it ideal for down translation.

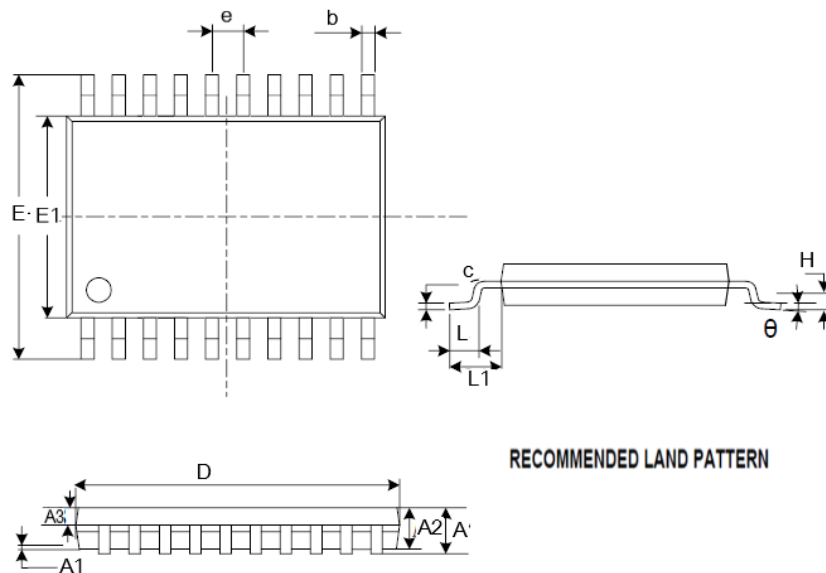


**Fig4 Typical Application Schematic**



**PACKAGE INFORMATION**

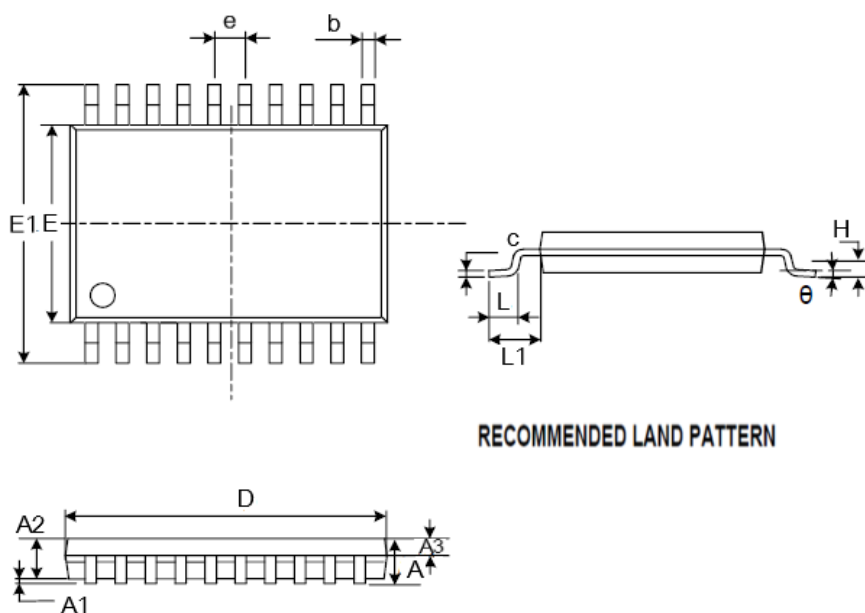
Dimension in SOP20 (Unit: mm)



Symbol	Millimeters	
	Min	Max
A	-	2.650
A1	0.100	0.300
A2	2.250	2.350
A2	0.970	1.070
b	0.390	0.470
c	0.250	0.290
D	12.700	12.900
E	10.100	10.500
E1	7.400	7.600
e	1.270 BSC	
L	0.700	1.000
H		
θ	0°	8°
L1	1.400 REF	



Dimension in TSSOP20 (Unit: mm)



Symbol	Millimeters	
	Min	Max
A	-	1.200
A1	0.050	0.150
A2	0.800	1.050
A3	0.390	0.490
b	0.200	0.290
c	0.130	0.170
D	6.400	6.600
E	4.300	4.500
E1	6.200	6.600
e	0.650(BSC)	
L	0.450	0.750
H	0.250TYP	
θ	0°	8°
L1	0.390(REF)	



## IMPORTANT NOTICE

AiT Semiconductor Inc. (AiT) reserves the right to make changes to any its product, specifications, to discontinue any integrated circuit product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

AiT Semiconductor Inc.'s integrated circuit products are not designed, intended, authorized, or warranted to be suitable for use in life support applications, devices or systems or other critical applications. Use of AiT products in such applications is understood to be fully at the risk of the customer. As used herein may involve potential risks of death, personal injury, or server property, or environmental damage. In order to minimize risks associated with the customer's applications, the customer should provide adequate design and operating safeguards.

AiT Semiconductor Inc. assumes to no liability to customer product design or application support. AiT warrants the performance of its products of the specifications applicable at the time of sale.